Leaded Varistors

Standard series

Series/Type:	**SIOV-S14K350**
Ordering code:	**B72214S 351K101**
Date:	2010-10-11
Version:	e

Applications

Overvoltage protection

Features

- UL approval to UL1449 (file number E321126), for use in Type 3 SPD's

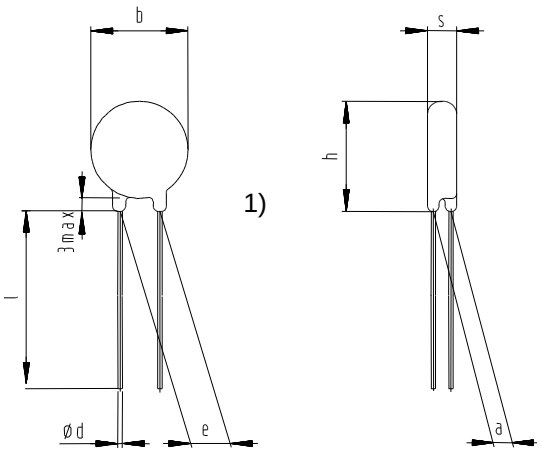
SIOV nomenclature

S	=	Disk type
14	=	Rated disk diameter
K	=	Tolerance of V_V at 1mA: ±10%
350	=	Max. AC operating voltage

General technical data

Climatic category	to IEC 60068-1	40/85/56	
Operating temperature	to CECC 42 000	–40 … + 85	°C
Storage temperature		–40 … +125	°C
Electric strength	to CECC 42 000	≥2.5	kV_{RMS}
Insulation resistance	to CECC 42 000	≥10	MΩ
Response time		<25	ns

Dimensional drawings in mm



b_{max}	=	15.5
h_{max}	=	19.0
s_{max}	=	5.5
e	=	7.5 ±1.0
l_{min}	=	25.0
a	=	2.5 ±1.0
∅d	=	0.8 ±0.05

[1] Seating plane in accordance with IEC 60717

Electrical data

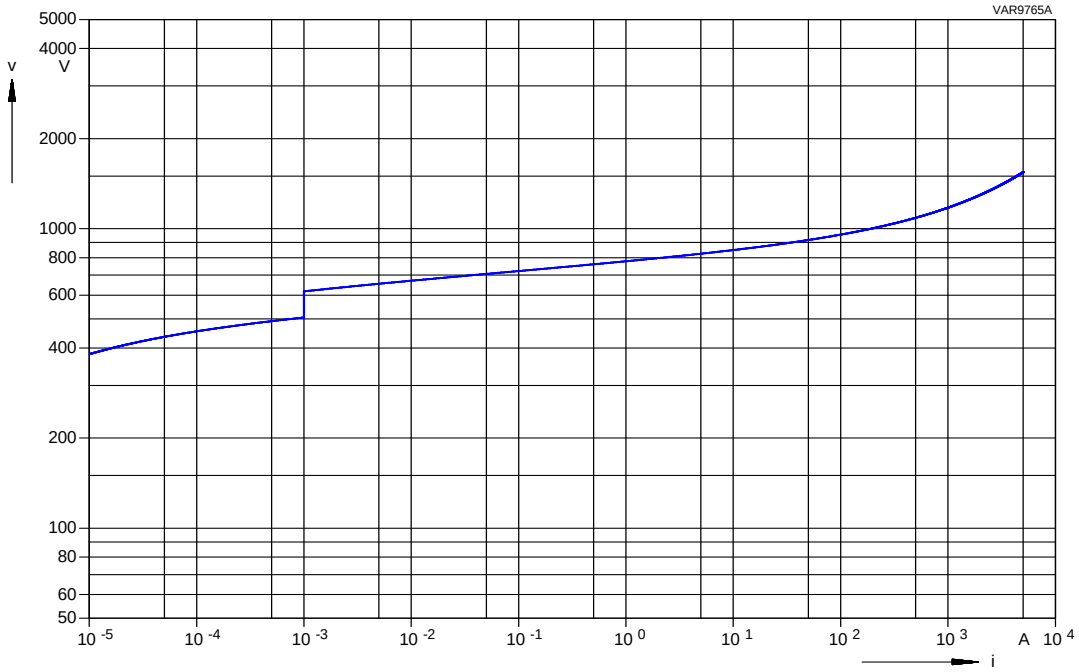
Maximum Ratings (85 °C):

Max. AC operating voltage		V_{RMS}	=	350 V
Max. DC operating voltage		V_{DC}	=	460 V
Surge current (8/20 µs)	1 time	I_{max}	=	4500 A
Energy absorption (2 ms)	1 time	W_{max}	=	80.0 J
Average power dissipation		P_{max}	=	0.6 W

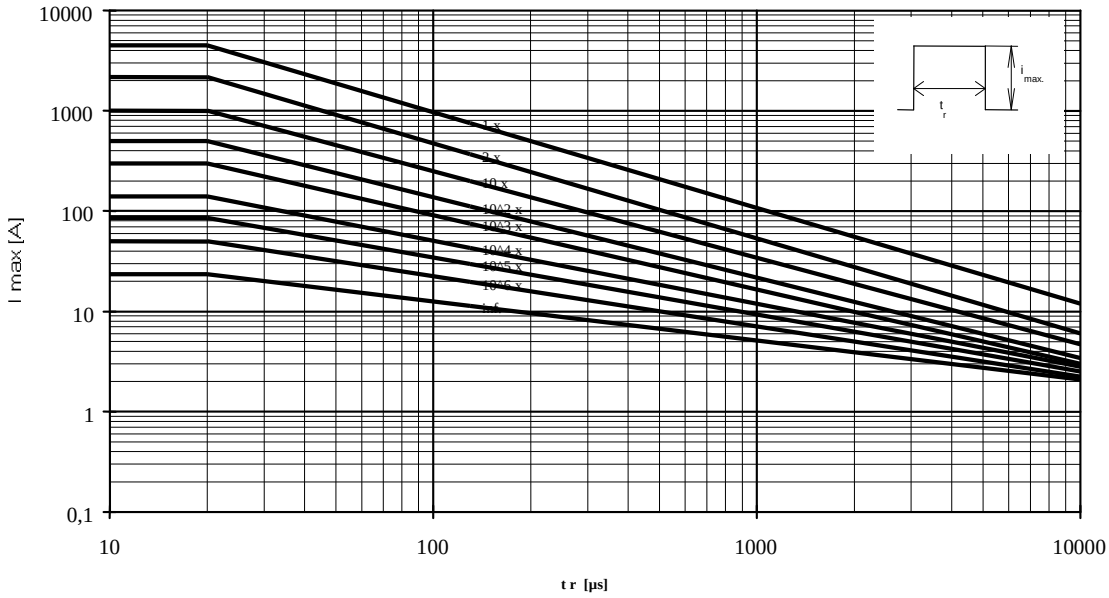
Characteristics (25 °C):

Varistor voltage at 1 mA	V_V	=	560 V ±10%
Clamping voltage at 50 A (8/20 µs)	$V_{C,max}$	=	910 V
Typ. capacitance at 1 kHz	C	=	265 pF

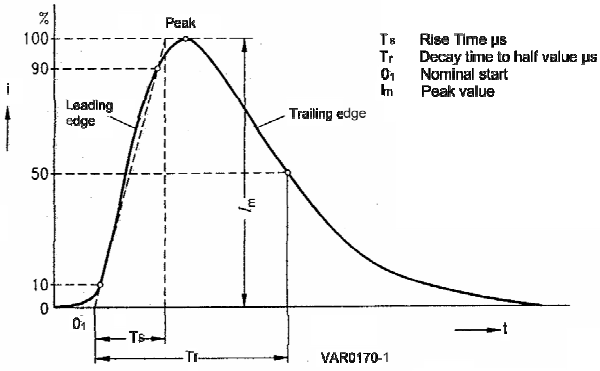
V/I Characteristic



Derating



Reliability Data Electrical

Characteristics	Test Methods/Description	Specifications
Varistor Voltage	The voltage between two terminals with the specified measuring current applied is called V_v (1 mA_{DC} @ 0.2 … 2 s).	To meet the specified value.
Clamping Voltage	The maximum voltage between two terminals with the specified standard impulse current (8/20µs) illustrated below applied. 	To meet the specified value.
Surge current derating, 8/20 µs	CECC 42 000, test C 2.1 100 surge currents (8/20 µs), unipolar, interval 30 s, amplitude corresponding to derating curve for 100 impulses at 20 µs	|ΔV/V (1 mA)| ≤10% (measured in direction of surge current) No visible damage
Surge current derating, 2 ms	CECC 42 000, test C 2.1 100 surge currents (2ms), unipolar, interval 120s, amplitude corresponding to derating curve for 100 impulses at 2 ms	|ΔV/V (1 mA)| ≤10% (measured in direction of surge current) No visible damage

Reliability Data Mechanical

Characteristics	Test Methods/Description	Specifications
Tensile strength	IEC 60068-2-21, test Ua1 After gradually applying the force specified below and keeping the unit fixed for 10 s, the terminal shall be visually examined for any damage. Force for wire diameter: 1.0 mm = 20 N	$\|\Delta V/V$ (1 mA)$\| \leq 5\%$ No break of solder joint, no wire break
Vibration	IEC 60068-2, test Fc Frequency range: 10 .... 55 Hz Amplitude: 0.75 mm or 98 m/s² Duration: 6 h (3 x 2 h) Pulse: sine wave After repeatedly applying a single harmonic vibration according to the table above, the change of V_v shall be measured and the part shall be visually examined.	$\|\Delta V/V$ (1 mA)$\| \leq 5\%$ No visible damage
Solderability	IEC 60068-2-20, test Ta, method 1 with modified conditions for lead-free solder alloys: 245℃, 3 s: After dipping the terminals to a depth of approximately 3 mm from the body in a soldering bath of 245 ℃ for 3 s, the terminals shall be visu ally examined.	The inspection shall be carried out under adequate light with normal eyesight or with the assistance of a magnifier capable of giving a magnification of 4 to 10 times. The dipped surface shall be covered with a smooth and bright solder coating with no more than small amounts of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.

Characteristics	Test Methods/Description	Specifications
Resistance to soldering heat	IEC 60068-2-20, test Tb, method 1A, 260 °C, 10 s: Each lead shall be dipped into a solder bath having a temperature of 260 ±5 °C to a point 2.0 to 2.5 mm from the body of the unit, be held there for 10 ±1 s and then be stored at room temperature and normal humidity for 1 to 2 hours. The change of V_v shall be measured and the part shall be visually examined.	$\lvert\Delta V/V\ (1\ mA)\rvert \leq 5\%$ No visible damage
Bump	IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400m/s^2 Number of bumps: 4000 Pulse: half sine	$\lvert\Delta V/V\ (1\ mA)\rvert \leq 5\%$ No visible damage
Flammability	IEC 60695-2-2 (needle flame test) Severity: vertical 10 s	5 s max.
Electric strength	CECC 42 000, test 4.7 Metal balls method, 2500 V_{RMS}, 60 s The varistor is placed in a container holding 1.6 ±0.2 mm diameter metal balls such that only the terminations of the varistor are protruding. The specified voltage shall be applied between both terminals of the specimen connected together and the electrode inserted between the metal balls.	No breakdown

Reliability Data Environmental

Characteristics	Test Methods/Description	Specifications
Max. AC operating voltage	CECC 42 000, test 4.20 1000 h at UCT After having continuously applied the maximum allowable voltage at UCT ±2 ℃ for 1000 h, the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_v shall be measured.	$\lvert\Delta V/V$ (1 mA)$\rvert \leq 10\%$
Damp heat, steady state	The specimen shall be subjected to 40 ±2 ℃, 90 to 95 % r.H. for 56 days without load / with 10% of the maximum continuous DC operating voltage V_{DC}. Then stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_v shall be measured. Thereafter, insulation resistance R_{ins} shall be measured according to CECC 42 000, test 4.8 at V = 500 V.	$\lvert\Delta V/V$ (1 mA)$\rvert \leq 10\%$ $R_{ins} \geq 1$ MΩ
Climatic sequence	CECC 42 000, test 4.16 The specimen shall be subjected to: a) dry heat at UCT, 16 h b) damp heat, 1st cycle: 55 ℃, 93% r.H., 24 h c) cold, LCT, 2 h d) damp heat, additional 5 cycles: 55 ℃/25 ℃, 93% r.H., 24 h/cycle. Then the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_v shall be measured. Thereafter, insulation resistance R_{ins} shall be measured according to CECC 42 000, test 4.8 at V = 500 V.	$\lvert\Delta V/V$ (1 mA)$\rvert \leq 10\%$ $R_{ins} \geq 1$ MΩ
Fast temperature cycling	IEC 60068-2-14, test Na, LCT/UCT, dwell time 30 min, 5 cycles	$\lvert\Delta V/V$ (1 mA)$\rvert \leq 5\%$ No visible damage

Note:

UCT = Upper category temperature

LCT = Lower category temperature

R_{ins} = Insulation resistance to CECC 42 000, test 4.8

Cautions and warnings

General

1. EPCOS metal oxide varistors (SIOVs) are designed for specific applications and should not be used for purposes not identified in our specifications, application notes and data books unless otherwise agreed with EPCOS during the design-in-phase.

2. Ensure suitability of SIOVs through reliability testing during the design-in phase. The SIOVs should be evaluated taking into consideration worst-case conditions.

3. For applications of SIOVs in line-to ground circuits based on various international and local standards there are restrictions existing or additional safety measures required.

Storage

1. Store SIOVs only in original packaging. Do not open the package before storage.

2. Storage conditions in original packaging:

Storage temperature:	-25 ℃ … +45 ℃
Relative humidity:	<75% annual average,
	<95% on maximum 30 days a year.
Dew precipitation:	Is to be avoided.

3. Avoid contamination of SIOVs surface during storage, handling and processing.

4. Avoid storage of SIOVs in harmful environments which can affect the function during long-term operation (examples given under operation precautions).

5. The SIOV type series should be soldered within the time specified.

SIOV-S, -Q, -LS	24 month
ETFV and SFS types	12 month.

Handling

1. SIOVs must not be dropped.

2. Components must not be touched with bare hands. Gloves are recommended.

3. Avoid contamination of the surface of SIOV electrodes during handling, be careful of the sharp edge of SIOV electrodes.

Soldering (where applicable)

1. Use rosin-type flux or non-activated flux.

2. Insufficient preheating may cause ceramic cracks.

3. Rapid cooling by dipping in solvent is not recommended.

4. Complete removal of flux is recommended.

Mounting

1. Potting, sealing or adhesive compounds can produce chemical reactions in the SIOV ceramic that will degrade the component's electrical characteristics.

2. Overloading SIOVs may result in ruptured packages and expulsion of hot materials. For this reason the SIOVs should be physically shielded from adjacent components.

Operation

1. Use SIOVs only within the specified temperature operating range

2. Use SIOVs only within the specified voltage and current ranges.

3. Environmental conditions must not harm the SIOVs. Use SIOVs only in normal atmospheric conditions. Avoid use in the presence of deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas, etc), corrosive agents, humid or salty conditions, Avoid contact with any liquids and solvents.

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